

## Description

The DMN10H170SK3 uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gat e charge. It can be used in a wide variety of applications.

### **General Features**

V<sub>DS</sub> =100V,I<sub>D</sub> =15A

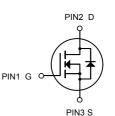
R<sub>DS(ON)</sub> <112m Ω @ V<sub>GS</sub>=10V

### Application

Power switch

DC/DC converters





N-Channel MOSFET

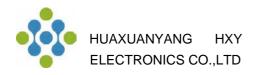
### Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
DMN10H170SK3	TO-252-2L	HXY MOSFET	2500

### Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	100	V
Vgs	Gate-Source Voltage	±20	V
I₀@Tc=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	15	А
I⊳@Tc=100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	7.7	А
I₀@T₄=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	3	А
I₀@T <sub>A</sub> =70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	2.4	А
Ідм	Pulsed Drain Current <sup>2</sup>	24	А
EAS	Single Pulse Avalanche Energy <sup>3</sup>	6.1	mJ
las	Avalanche Current	11	Α
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>3</sup>	34.7	W
P <sub>D</sub> @T <sub>A</sub> =25°C	Total Power Dissipation <sup>3</sup>	2	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-ambient <sup>1</sup>	62	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	3.6	°C/W

N-Channel Enhancement Mode MOSFET



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	100			V	
2BVbss/2TJ	BVDSS Temperature Coefficient	Reference to 25°C , ID=1mA		0.098		V/°C	
		V <sub>GS</sub> =10V , I <sub>D</sub> =10A		100	112	$\mathbf{m}  \Omega$	
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =8A		117	130	$\mathbf{m}  \Omega$	
$V_{GS(th)}$	Gate Threshold Voltage		1.0		2.5	V	
₪VGS(th)	V <sub>GS(th)</sub> Temperature Coefficient	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA		-4.57		mV/°C	
		V <sub>DS</sub> =80V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1		
ldss	Drain-Source Leakage Current	V <sub>DS</sub> =80V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	uA	
Igss	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =10A		13		S	
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2		Ω	
Qg	Total Gate Charge (10V)			26.2			
Qgs	Gate-Source Charge	V <sub>DS</sub> =80V , V <sub>GS</sub> =10V , I <sub>D</sub> =10A		4.6		nC	
Qgd	Gate-Drain Charge			5.1			
Td(on)	Turn-On Delay Time			4.2			
Tr	Rise Time	──V <sub>DD</sub> =50V,V <sub>GS</sub> =10V, ──R <sub>G</sub> =3.3		8.2			
Td(off)	Turn-Off Delay Time	RG=3.3 ID=10A		35.6		ns	
Tf	Fall Time			9.6			
Ciss	Input Capacitance			1535			
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		60		pF	
Crss	Reverse Transfer Capacitance			37			
ls	Continuous Source Current <sup>1,5</sup>				12	Α	
lsм	Pulsed Source Current <sup>2,5</sup> V <sub>G</sub> =V <sub>D</sub> =0V , Force Current				24	А	
Vsd	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1.2	V	
trr	Reverse Recovery Time			37		nS	
Qrr	Reverse Recovery Charge	IF=10A , dI/dt=100A/μs , T <sub>J</sub> =25°C		27.3		nC	

### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Note :

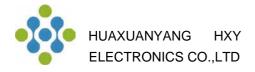
1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width  $\leqq$  300us , duty cycle  $\leqq$  2%

3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH,  $I_{AS}$ =11A

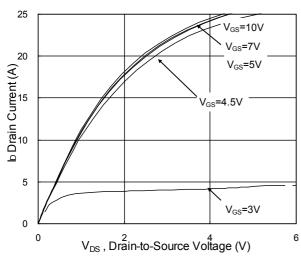
4.The power dissipation is limited by 150°C junction temperature

 $5\,$  .The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.



# DMN10H170SK3 N-Channel Enhancement Mode MOSFET

## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

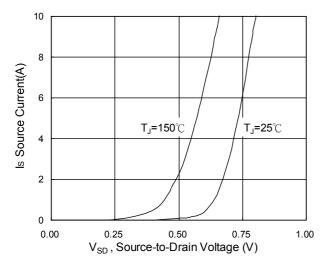


Fig.3 Forward Characteristics Of Reverse

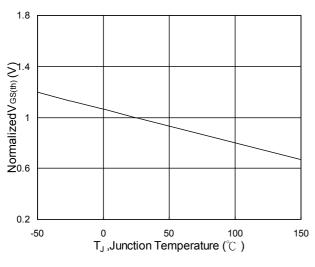


Fig.5 Normalized  $V_{\text{GS}(\text{th})}$  vs.  $T_{\text{J}}$ 

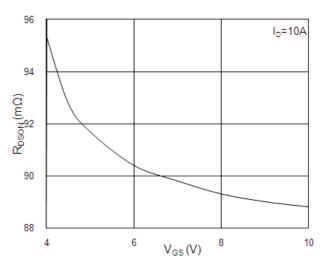


Fig.2 On-Resistance vs. Gate-Source

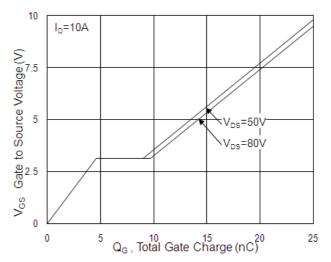


Fig.4 Gate-Charge Characteristics

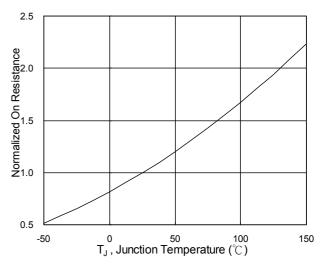
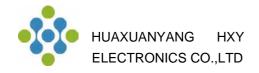
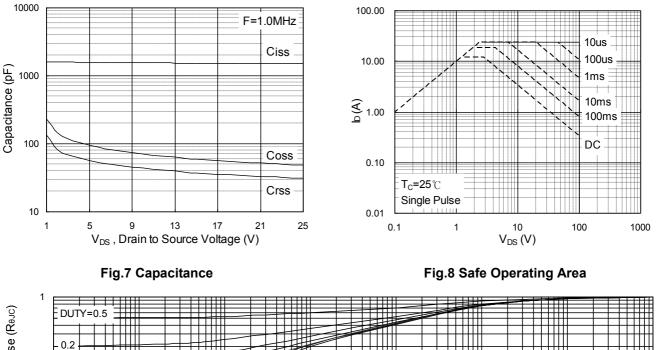


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



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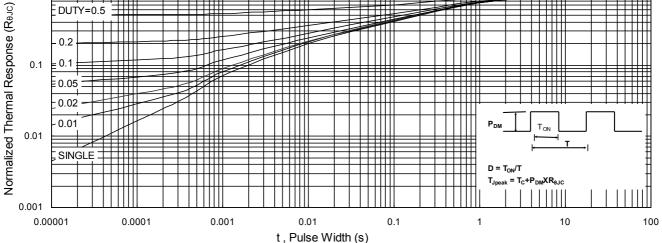


Fig.9 Normalized Maximum Transient Thermal Impedance

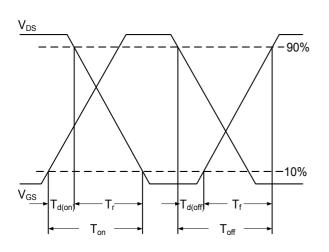
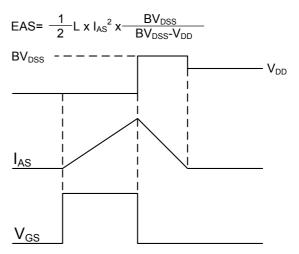


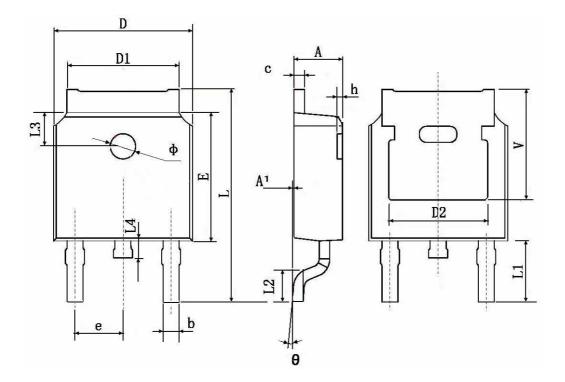
Fig.10 Switching Time Waveform



### Fig.11 Unclamped Inductive Switching Waveform



# **TO-252-2L Package Information**



Quantant	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	0.483	0.483 TYP.		.190 TYP.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900	) TYP.	0.11	4 TYP.	
L2	1.400	1.700	0.055	0.067	
L3	1.600	1.600 TYP. 0.063 TYP.		3 TYP.	
L4	0.600	1.000	0.024	0.039	
Φ	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350	) TYP.	0.211 TYP.		



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